

<b>Notice of References Cited</b>	Application/Control No. 10/575,174	Applicant(s)/Patent Under Reexamination MIURA, YUKI	
	Examiner KYLE STORK	Art Unit 2178	Page 1 of 1

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*	B	US-7,197,702	03-2007	Niyogi et al.	715/234
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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